

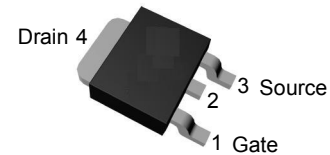
Features

- -200V/-8A,
 $R_{DS(ON)} = 680m\Omega$ (max.) @ $V_{GS} = -10V$
- 100% UIS + R_g Tested
- Reliable and Rugged
- Lead Free and Green Devices Available
(RoHS Compliant)

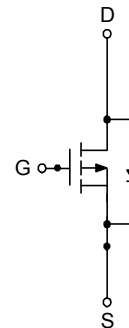
Applications

- Power Management for Industrial DC / DC Converters.
- Load switch.

Pin Description



Top View of TO-252-2



P-Channel MOSFET

Absolute Maximum Ratings

Symbol	Parameter		Rating	Unit
Common Ratings				
V _{DSS}	Drain-Source Voltage		-200	V
V _{GSS}	Gate-Source Voltage		±20	
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to 150	
I _S	Diode Continuous Forward Current	T _A =25°C	-8	A
I _D	Continuous Drain Current	T _A =25°C	-8	A
		T _A =70°C	-4.8	
I _{DM} ^a	Pulsed Drain Current	T _A =25°C	-6.8	
P _D	Maximum Power Dissipation	T _A =25°C	1.78	W
		T _A =70°C	1.14	
R _{θJA} ^b	Thermal Resistance-Junction to Ambient		70	°C/W
I _{AS} ^c	Avalanche Current, Single pulse	L=0.5mH	14	A
E _{AS} ^c	Avalanche Energy, Single pulse	L=0.5mH	49	mJ

Note a : Pulse width limited by maximum junction temperature.

Note b : Surface mounted on 1in² pad area.

Note c : UIS tested and pulse width limited by maximum junction temperature 150 $^{\circ}\text{C}$ (initial temperature $T_J=25^{\circ}\text{C}$).

Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =-250μA	-200	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-120V, V _{GS} =0V T _J =85°C	-	-	-1 -30	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =-250μA	-2	-3	-4	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^d	Drain-Source On-state Resistance	V _{GS} =-10V, I _{DS} =-4A	-	-	680	mΩ
Diode Characteristics						
V _{SD} ^d	Diode Forward Voltage	I _{SD} =-1A, V _{GS} =0V	-	-0.75	-1.1	V
t _{rr}	Reverse Recovery Time	I _{SD} =-1.6A, dI _{SD} /dt=100A/μs	-	40	-	ns
Q _{rr}	Reverse Recovery Charge		-	83	-	nC
Dynamic Characteristics ^e						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	-	13	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-30V, Frequency=1.0MHz	-	910	1200	pF
C _{oss}	Output Capacitance		-	82	-	
C _{rss}	Reverse Transfer Capacitance		-	37	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =-30V, R _L =30Ω, I _{DS} =-1A, V _{GEN} =-10V, R _G =6Ω	-	11	20	ns
t _r	Turn-on Rise Time		-	9	17	
t _{d(OFF)}	Turn-off Delay Time		-	51	92	
t _f	Turn-off Fall Time		-	25	45	
Gate Charge Characteristics ^e						
Q _g	Total Gate Charge	V _{DS} =-75V, V _{GS} =-10V, I _{DS} =-1.6A	-	20	28	nC
Q _{gs}	Gate-Source Charge		-	4.3	-	
Q _{gd}	Gate-Drain Charge		-	5.3	-	

Note d : Pulse test; pulse width≤300μs, duty cycle≤2%.

Note e : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

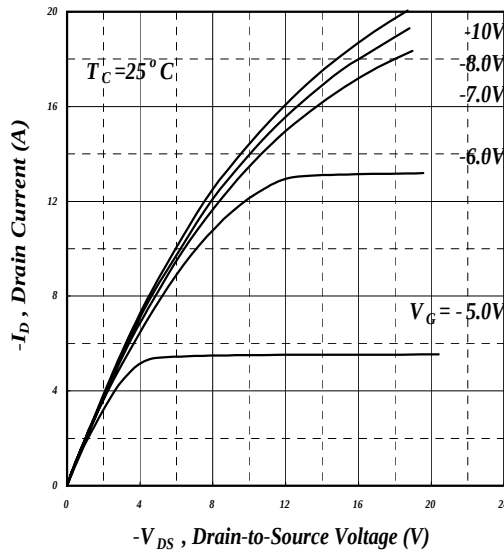


Fig 1. Typical Output Characteristics

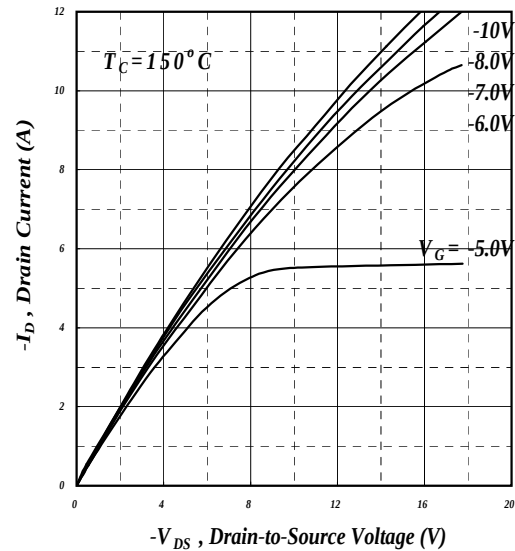


Fig 2. Typical Output Characteristics

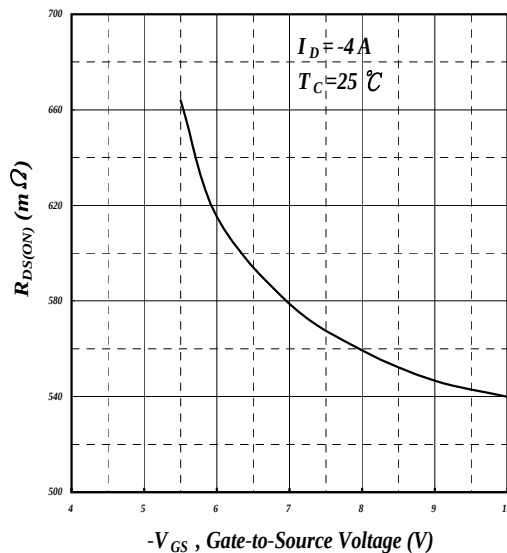
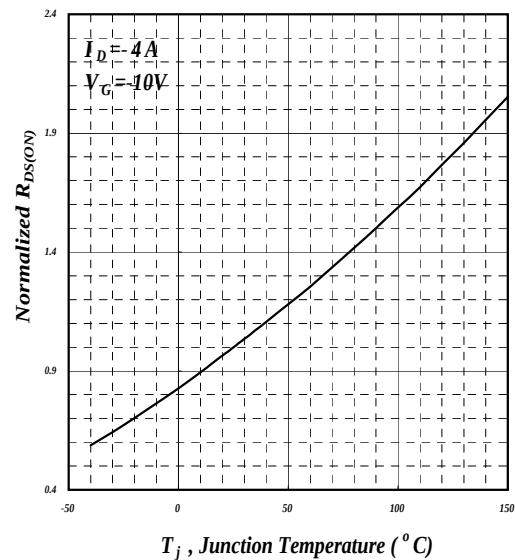


Fig 3. On-Resistance v.s. Gate Voltage



**Fig 4. Normalized On-Resistance
v.s. Junction Temperature**

Typical Operating Characteristics (Cont.)

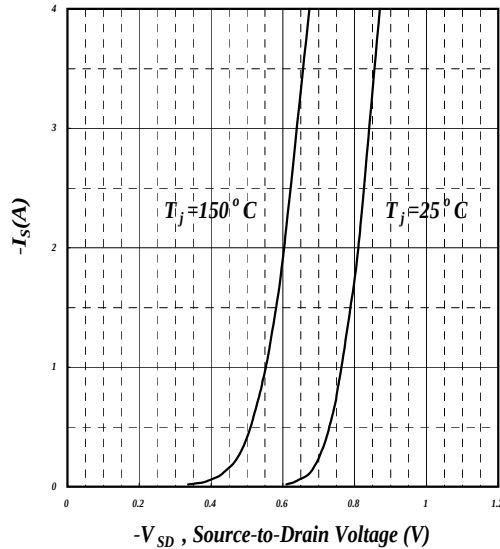


Fig 5. Forward Characteristic of Reverse Diode

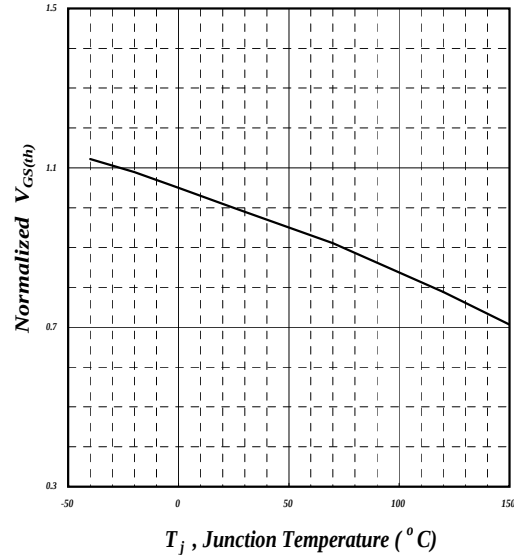


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

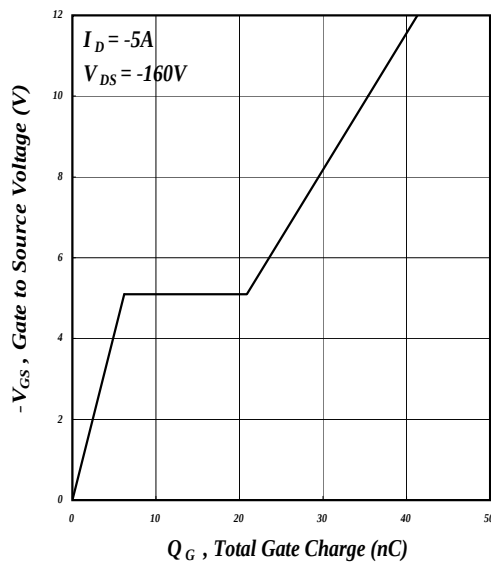


Fig 7. Gate Charge Characteristics

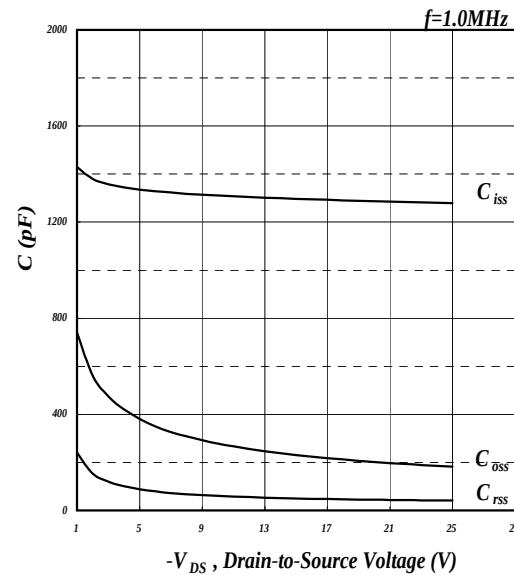


Fig 8. Typical Capacitance Characteristics

Typical Operating Characteristics (Cont.)

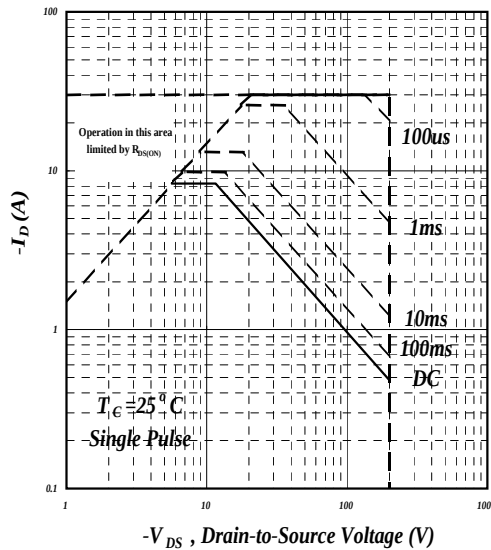


Fig 9. Maximum Safe Operating Area

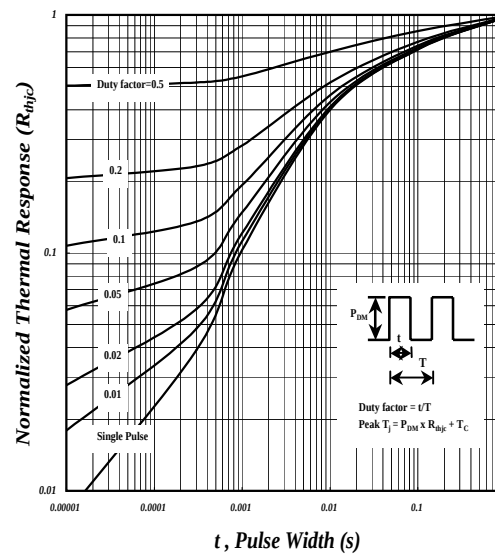


Fig 10. Effective Transient Thermal Impedance

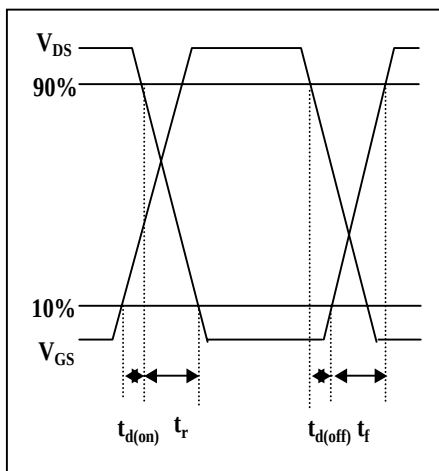


Fig 11. Switching Time Waveform

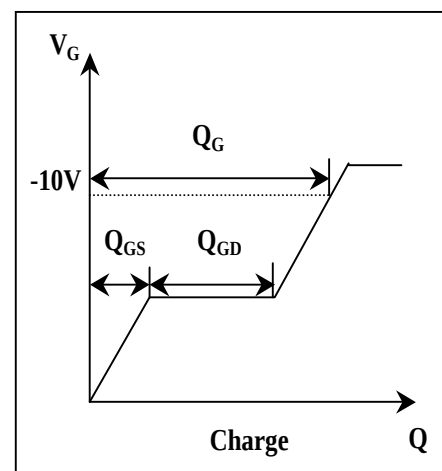
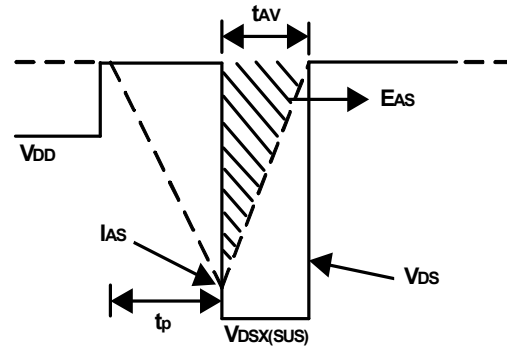
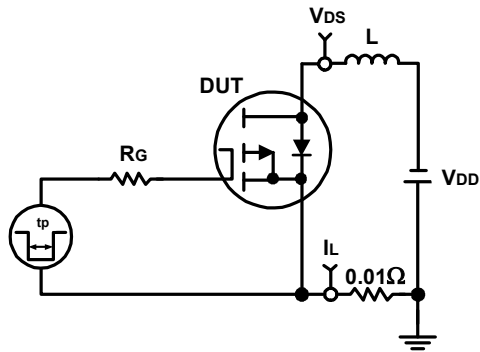
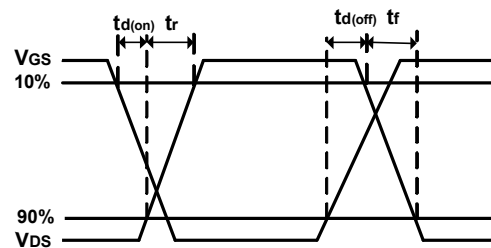
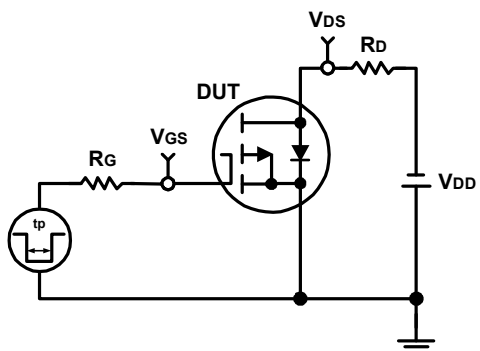


Fig 12. Gate Charge Waveform

Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms



Package Information

